

Search Notes



Application/Control No.

10/727,363

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

BOTICH ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	162	7/24/2006	mlh.
	164.01		
	164.07		
	164.08		
	164.09		
	165.01		
	171		
	187		
	192		
	198		
	263		
	264		
	272		
	533		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	7/24/2006	mlh.